

PMZ390UN

N-channel TrenchMOS standard level FET

Rev. 01 — 12 July 2007

Product data sheet

Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Profile 55 % lower than SOT23
- Low on-state resistance
- Leadless package

- Footprint 90 % smaller than SOT23
- Fast switching
- Standard level compatible threshold

1.3 Applications

Driver circuits

Load switching in portable appliances

1.4 Quick reference data

- $V_{DS} \le 30 \text{ V}$
- $R_{DSon} \le 460 \text{ m}\Omega$

- $I_D \le 1.78 \text{ A}$
- $P_{tot} \le 2.50 \text{ W}$

Pinning information 2.

lable	1.	Pin	nın	g
		_		

10010 11	9		
Pin	Description	Simplified outline	Symbol
1	gate (G)		_
2	source (S)	1 3	D
3	drain (D)	2	$G \longrightarrow \overline{A}$
		Transparent top view	
		SOT883 (SC-101)	mbb076 S



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3. Ordering information

Table 2. Ordering information

Type number	Package				
	Name	Description	Version		
PMZ390UN	SC-101	leadless ultra small plastic package; 3 solder lands; body 1.0 \times 0.6 \times 0.5 mm	SOT883		

4. Limiting values

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

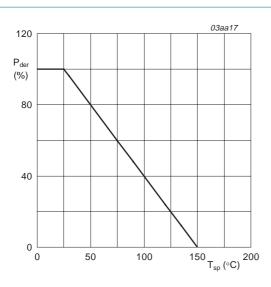
Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

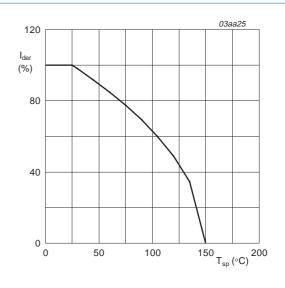
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _i ≤ 150 °C	-	30	V
V_{DGR}	drain-gate voltage (DC)	$25 ^{\circ}\text{C} \le \text{T}_{\text{j}} \le 150 ^{\circ}\text{C}; \text{R}_{\text{GS}} = 20 \text{k}\Omega$	-	30	V
V_{GS}	gate-source voltage		-	±8	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see <u>Figure 2</u> and <u>3</u>	-	1.78	Α
		$T_{mb} = 100 ^{\circ}\text{C}; V_{GS} = 10 \text{V}; \text{see} \frac{\text{Figure 2}}{}$	-	1.13	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3	-	3.56	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>	-	2.50	W
T _{stg}	storage temperature		-55	+150	°C
Tj	junction temperature		-55	+150	°C
Source-	drain diode				
Is	source current	T _{mb} = 25 °C	-	1.78	Α
I _{SM}	peak source current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$	-	3.56	Α
Electros	tatic discharge				
V _{esd}	electrostatic discharge voltage	all pins			
		human body model; C = 100 pF; R = 1.5 k Ω	-	60	V
		machine model; C = 200 pF	-	30	V

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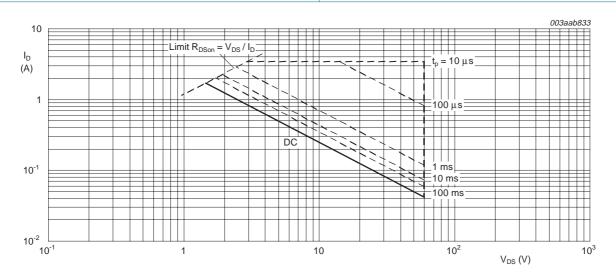
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature



 T_{mb} = 25 °C; I_{DM} is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

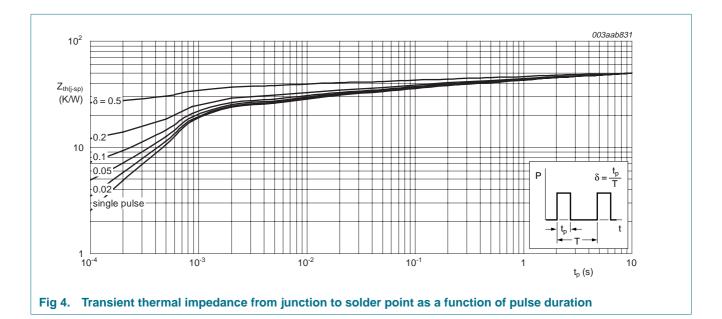
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5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{\text{th(j-sp)}}$	thermal resistance from junction to solder point	see Figure 4	-	-	50	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient		<u>[1]</u> _	670	-	K/W

[1] Mounted on a printed-circuit board; vertical in still air.



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6. Characteristics

Table 5. Characteristics

 $T_j = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	aracteristics					
V _{(BR)DSS} drain-source breakdown	$I_D = 10 \mu A; V_{GS} = 0 V$					
	voltage	T _j = 25 °C	30	-	-	V
		T _j = −55 °C	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 0.25 \text{ mA}$; $V_{DS} = V_{GS}$; see Figure 9 and 10				
		T _j = 25 °C	0.45	0.7	0.95	V
		T _j = 150 °C	0.25	-	-	V
		T _j = −55 °C	-	-	1.15	V
I _{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	-	1	μΑ
		T _j = 150 °C	-	-	100	μΑ
I_{GSS}	gate leakage current	$V_{GS} = \pm 8 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nΑ
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}$; $I_D = 0.2 \text{ A}$; see Figure 6 and 8				
resistance	resistance	T _j = 25 °C	-	390	460	$m\Omega$
	T _j = 150 °C	-	663	782	$m\Omega$	
	$V_{GS} = 2.5 \text{ V}$; $I_D = 0.1 \text{ A}$; see Figure 6 and 8	-	460	560	$m\Omega$	
		V_{GS} = 1.8 V; I_D = 0.075 A; see <u>Figure 6</u> and <u>8</u>	-	550	730	$m\Omega$
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 1 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	0.89	-	nC
Q_{GS}	gate-source charge	see Figure 11 and 12	-	0.1	-	nC
Q_{GD}	gate-drain charge		-	0.2	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	43	-	pF
C _{oss}	output capacitance	see Figure 14	-	7.7	-	pF
C _{rss}	reverse transfer capacitance		-	4.8	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 15 V; R_L = 15 Ω ; V_{GS} = 10 V; R_G = 6 Ω	-	4	-	ns
t _r	rise time		-	7.5	-	ns
t _{d(off)}	turn-off delay time		-	18	-	ns
t _f	fall time		-	4.5	-	ns
Source-d	drain diode					
V_{SD}	source-drain voltage	$I_S = 0.3 \text{ A}$; $V_{GS} = 0 \text{ V}$; see <u>Figure 13</u>	-	0.76	1.2	V

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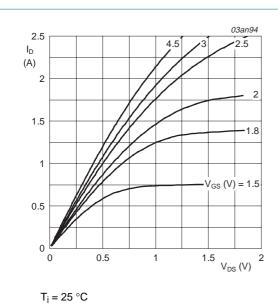


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

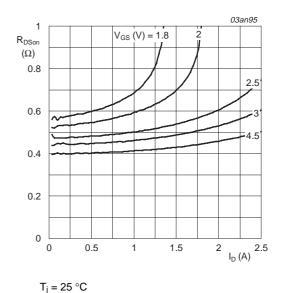
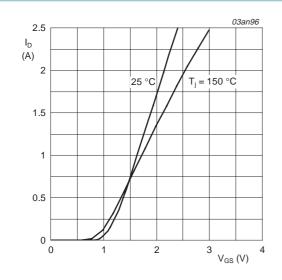
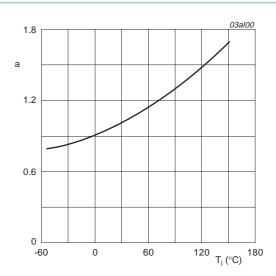


Fig 6. Drain-source on-state resistance as a function of drain current; typical values



 T_j = 25 °C and 150 °C; $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

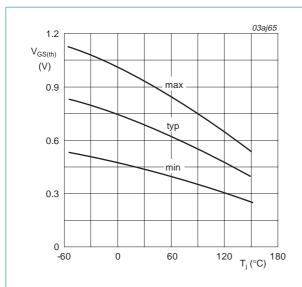


$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

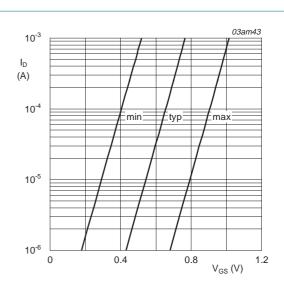
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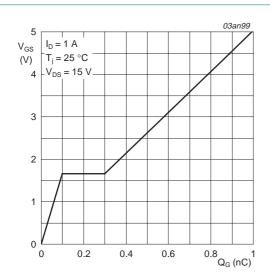
 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



 T_j = 25 °C; V_{DS} = 5 V

Fig 10. Sub-threshold drain current as a function of gate-source voltage



I_D = 1 A; V_{DS} = 15 V

Fig 11. Gate-source voltage as a function of gate charge; typical values

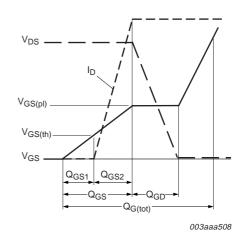
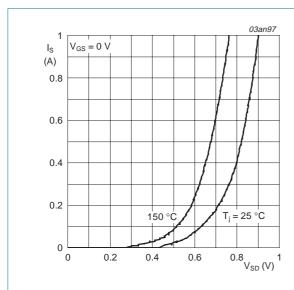


Fig 12. Gate charge waveform definitions

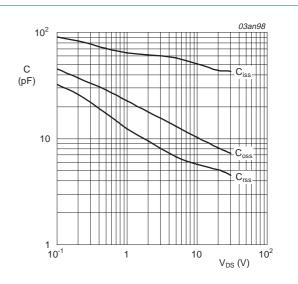
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 T_j = 25 °C and 150 °C; V_{GS} = 0 V

Fig 13. Source current as a function of source-drain voltage; typical values



 $V_{GS} = 0 V$; f = 1 MHz

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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7. Package outline

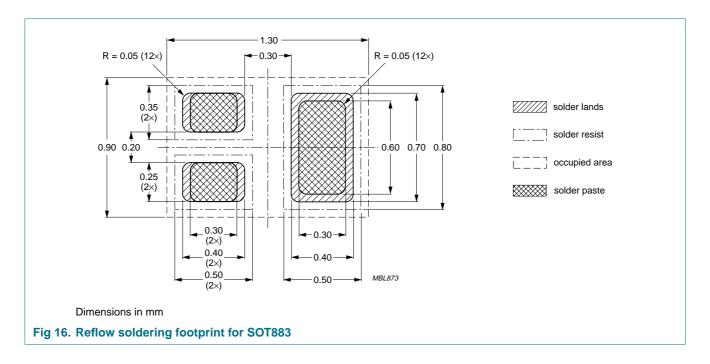
Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm **SOT883** e₁ 0.5 1 mm DIMENSIONS (mm are the original dimensions) UNIT b_1 D Ε е L_1 e₁ 0.50 0.20 0.55 0.62 1.02 0.30 0.30 mm 0.03 0.35 0.65 0.46 0.95 0.22 0.22 1. Including plating thickness REFERENCES EUROPEAN OUTLINE ISSUE DATE VERSION **PROJECTION** IEC **JEDEC JEITA** 03-02-05 SOT883 SC-101

Fig 15. Package outline SO883 (SC-101)

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8. Soldering



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9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMZ390UN _1	20070712	Product data sheet	-	-

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10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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